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MC14016B

Quad Analog Switch/ Quad Multiplexer

The MC14016B quad bilateral switch is constructed with MOS P−channel and N−channel enhancement mode devices in a single monolithic structure. Each MC14016B consists of four independent switches capable of controlling either digital or analog signals. The quad bilateral switch is used in signal gating, chopper, modulator, demodulator and CMOS logic implementation.

Features

- Diode Protection on All Inputs
- Supply Voltage Range = 3.0 Vdc to 18 Vdc
- Linearized Transfer Characteristics
- Low Noise − 12 nV/$\sqrt{\text{Cycle}}$, f ≥ 1.0 kHz typical
- Pin−for−Pin Replacements for CD4016B, CD4066B (Note Improved Transfer Characteristic Design Causes More Parasitic Coupling Capacitance than CD4016)
- For Lower R_{ON}, Use The HC4016 High−Speed CMOS Device or The MC14066B
- This Device Has Inputs and Outputs Which Do Not Have ESD Protection. Antistatic Precautions Must Be Taken
- NLV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC−Q100 Qualified and PPAP Capable
- These Devices are Pb−Free and are RoHS Compliant

MAXIMUM RATINGS (Voltages Referenced to V_{SS})

Symbol	Parameter	Value	Unit
V_{DD}	DC Supply Voltage Range	−0.5 to +18.0	V
V_{in}, V_{out}	Input or Output Voltage Range (DC or Transient)	−0.5 to V_{DD} + 0.5	V
I_{in}	Input Current (DC or Transient) per Control Pin	±10	mA
I_{SW}	Switch Through Current	±25	mA
P_D	Power Dissipation, per Package (Note 1)	500	mW
T_A	Ambient Temperature Range	−55 to +125	°C
T_{stg}	Storage Temperature Range	−65 to +150	°C
T_L	Lead Temperature (8−Second Soldering)	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Temperature Derating: “D/DW” Packages: –7.0 mW/°C From 65°C To 125°C

This device contains protection circuitry to guard against damage due to high static voltages or electric fields. However, precautions must be taken to avoid applications of any voltage higher than maximum rated voltages to this high−impedance circuit. For proper operation, V_{in} and V_{out} should be constrained to the range $V_{SS} \leq (V_{in}$ or $V_{out}) \leq V_{DD}$.

Unused inputs must always be tied to an appropriate logic voltage level (e.g., either V_{SS} or V_{DD}). Unused outputs must be left open.

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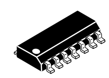
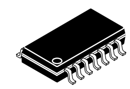
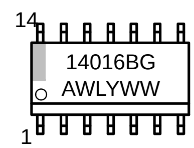


SOIC−14
D SUFFIX
CASE 751A



SOEIAJ−14
F SUFFIX
CASE 965

MARKING DIAGRAMS



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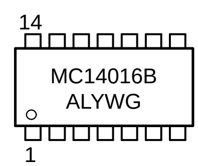


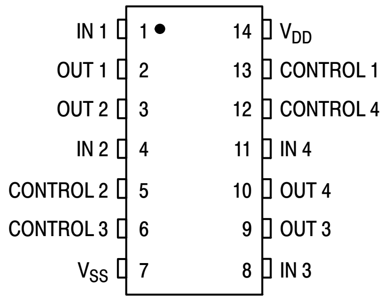
SOEIAJ−14

A	= Assembly Location
WL, L	= Wafer Lot
YY, Y	= Year
WW, W	= Work Week
G	= Pb−Free Indicator

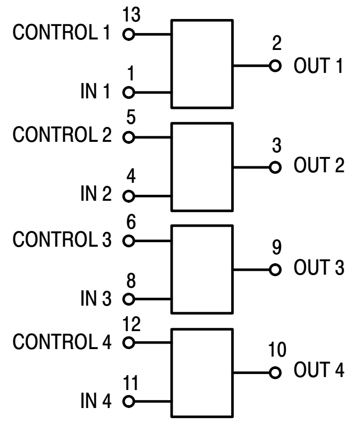
ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

PIN ASSIGNMENT



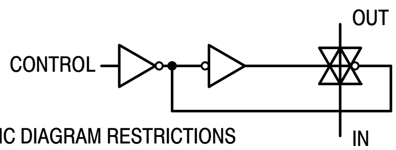
BLOCK DIAGRAM



V_{DD} = PIN 14
V_{SS} = PIN 7

LOGIC DIAGRAM

(1/4 OF DEVICE SHOWN)



LOGIC DIAGRAM RESTRICTIONS
$V_{SS} \leq V_{in} \leq V_{DD}$
$V_{SS} \leq V_{out} \leq V_{DD}$

Control	Switch
0 = V_{SS}	Off
1 = V_{DD}	On

ORDERING INFORMATION

Device	Package	Shipping†
MC14016BDG	SOIC−14 (Pb−Free)	55 Units / Rail
MC14016BDR2G	SOIC−14 (Pb−Free)	2500 / Tape & Reel
NLV14016BDR2G*	SOIC−14 (Pb−Free)	2500 / Tape & Reel
MC14016BFELG	SOEIAJ−14 (Pb−Free)	2000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.
*NLV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC−Q100 Qualified and PPAP Capable.

ELECTRICAL CHARACTERISTICS (Voltages Referenced to V_{SS})

Characteristic	Figure	Symbol	V_{DD} Vdc	−55°C Min	−55°C Max	25°C Min	25°C Typ (Note 2)	25°C Max	125°C Min	125°C Max	Unit
Input Voltage	1	V_{IL}	5.0	–	–	–	1.5	0.9	–	–	Vdc
Control Input			10	–	–	–	1.5	0.9	–	–	
			15	–	–	–	1.5	0.9	–	–	
		V_{IH}	5.0	–	–	3.0	2.0	–	–	–	Vdc
			10	–	–	8.0	6.0	–	–	–	
			15	–	–	13	11	–	–	–	
Input Current Control	–	I_{in}	15	–	±0.1	–	±0.00001	±0.1	–	±1.0	μAdc
Input Capacitance	–	C_{in}									pF
Control			–	–	–	–	5.0	–	–	–	
Switch Input			–	–	–	–	5.0	–	–	–	
Switch Output			–	–	–	–	5.0	–	–	–	
Feed Through			–	–	–	–	0.2	–	–	–	
Quiescent Current	2,3	I_{DD}	5.0	–	0.25	–	0.0005	0.25	–	7.5	μAdc
(Per Package) (Note 3)			10	–	0.5	–	0.0010	0.5	–	15	
			15	–	1.0	–	0.0015	1.0	–	30	
“ON” Resistance ($V_C = V_{DD}$, R_L = 10 kΩ)	4,5,6	R_{ON}									Ω
(V_{in} = +10 Vdc)				–	600	–	260	660	–	840	
(V_{in} = +0.25 Vdc) V_{SS} = 0 Vdc				–	600	–	310	660	–	840	
(V_{in} = +5.6 Vdc)			10	–	600	–	310	660	–	840	
(V_{in} = +15 Vdc)				–	360	–	260	400	–	520	
(V_{in} = +0.25 Vdc) V_{SS} = 0 Vdc				–	360	–	260	400	–	520	
(V_{in} = +9.3 Vdc)			15	–	360	–	300	400	–	520	
Δ “ON” Resistance Between any 2 circuits in a common package ($V_C = V_{DD}$)	–	ΔR_{ON}									Ω
(V_{in} = +5.0 Vdc, V_{SS} = −5.0 Vdc)			5.0	–	–	–	15	–	–	–	
(V_{in} = +7.5 Vdc, V_{SS} = −7.5 Vdc)			7.5	–	–	–	10	–	–	–	
Input/Output Leakage Current ($V_C = V_{SS}$)	–	–									μAdc
(V_{in} = +7.5, V_{out} = −7.5 Vdc)			7.5	–	±0.1	–	±0.0015	±0.1	–	±1.0	
(V_{in} = −7.5, V_{out} = +7.5 Vdc)			7.5	–	±0.1	–	±0.0015	±0.1	–	±1.0	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

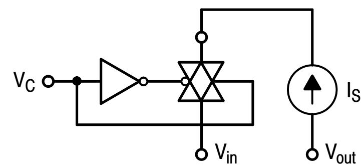
NOTE: All unused inputs must be returned to V_{DD} or V_{SS} as appropriate for the circuit application.

2. Data labelled “Typ” is not to be used for design purposes but is intended as an indication of the IC’s potential performance.
3. For voltage drops across the switch (ΔV_{switch}) > 600 mV (> 300 mV at high temperature), excessive V_{DD} current may be drawn; i.e., the current out of the switch may contain both V_{DD} and switch input components. The reliability of the device will be unaffected unless the Maximum Ratings are exceeded. (See first page of this data sheet.) Reference Figure 14.

ELECTRICAL CHARACTERISTICS (Note 4) (C_L = 50 pF, T_A = 25°C)

Characteristic	Figure	Symbol	V_{DD} Vdc	Min	Typ (Note 5)	Max	Unit
Propagation Delay Time (V_{SS} = 0 Vdc) V_{in} to V_{out} ($V_C = V_{DD}$, R_L = 10 kΩ)	7	t_{PLH}, t_{PHL}	5.0 10 15	– – –	15 7.0 6.0	45 20 15	ns
Control to Output (V_{in} ≤ 10 Vdc, R_L = 10 kΩ)	8	t_{PHZ}, t_{PLZ}, t_{PZH}, t_{PZL}	 5.0 10 15	 – – –	 34 20 15	 120 110 100	ns
Crosstalk, Control to Output (V_{SS} = 0 Vdc) ($V_C = V_{DD}$, R_{in} = 10 kΩ, R_{out} = 10 kΩ, f = 1.0 kHz)	9	–	5.0 10 15	– – –	30 50 100	– – –	mV
Crosstalk between any two switches (V_{SS} = 0 Vdc) (R_L = 1.0 kΩ, f = 1.0 MHz, $\text{crosstalk} = 20\log_{10}\frac{V_{out1}}{V_{out2}}$)	–	–	5.0	–	– 80	–	dB
Noise Voltage (V_{SS} = 0 Vdc) ($V_C = V_{DD}$, f = 100 Hz) ($V_C = V_{DD}$, f = 100 kHz)	10,11	–	5.0 10 15 5.0 10 15	– – – – – –	24 25 30 12 12 15	– – – – – –	nV/$\sqrt{\text{Cycle}}$
Second Harmonic Distortion (V_{SS} = – 5.0 Vdc) (V_{in} = 1.77 Vdc, RMS Centered @ 0.0 Vdc, R_L = 10 kΩ, f = 1.0 kHz)	–	–	5.0	–	0.16	–	%
Insertion Loss ($V_C = V_{DD}$, V_{in} = 1.77 Vdc, V_{SS} = −5.0 Vdc, RMS centered = 0.0 Vdc, f = 1.0 MHz) $I_{loss} = 20\log_{10}\frac{V_{out}}{V_{in}}$) ($R_L$ = 1.0 kΩ) (R_L = 10 kΩ) (R_L = 100 kΩ) (R_L = 1.0 MΩ)	12	–	5.0	 – – – –	 2.3 0.2 0.1 0.05	 – – – –	dB
Bandwidth (−3.0 dB) ($V_C = V_{DD}$, V_{in} = 1.77 Vdc, V_{SS} = −5.0 Vdc, RMS centered @ 0.0 Vdc) (R_L = 1.0 kΩ) (R_L = 10 kΩ) (R_L = 100 kΩ) (R_L = 1.0 MΩ)	12,13	BW	5.0	 – – – –	 54 40 38 37	 – – – –	MHz
OFF Channel Feedthrough Attenuation (V_{SS} = −5.0 Vdc) ($V_C = V_{SS}$, $20\log_{10}\frac{V_{out}}{V_{in}} = -50\,\text{dB}$) ($R_L$ = 1.0 kΩ) (R_L = 10 kΩ) (R_L = 100 kΩ) (R_L = 1.0 MΩ)	–	–	5.0	 – – – –	 1250 140 18 2.0	 – – – –	kHz

4. The formulas given are for typical characteristics only at 25°C.
5. Data labelled “Typ” is not to be used for design purposes but is intended as an indication of the IC’s potential performance.



V_{IL}: V_C is raised from V_{SS} until $V_C = V_{IL}$.
at $V_C = V_{IL}$: $I_S = \pm 10\ \mu A$ with $V_{in} = V_{SS}$, $V_{out} = V_{DD}$ or $V_{in} = V_{DD}$, $V_{out} = V_{SS}$.

V_{IH}: When $V_C = V_{IH}$ to V_{DD}, the switch is ON and the R_{ON} specifications are met.

Figure 1. Input Voltage Test Circuit

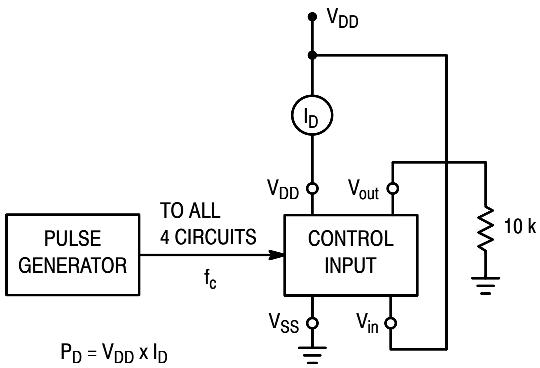


Figure 2. Quiescent Power Dissipation Test Circuit

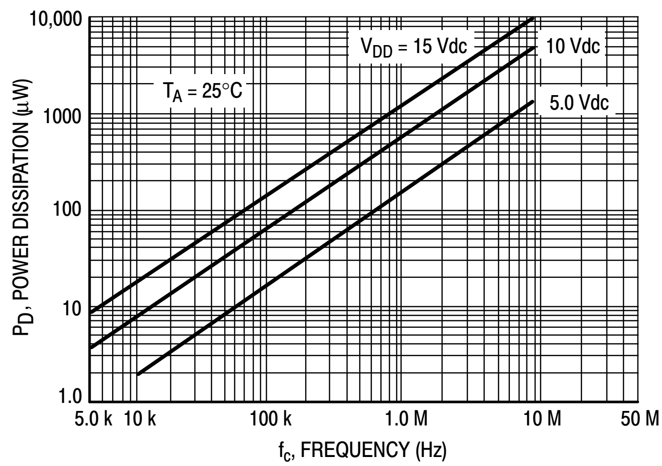


Figure 3. Typical Power Dissipation per Circuit (1/4 of device shown)

TYPICAL R_{ON} versus INPUT VOLTAGE

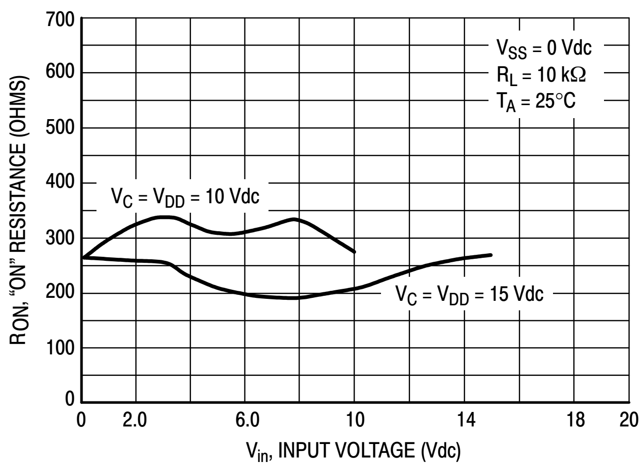


Figure 4. V_{SS} = 0 V

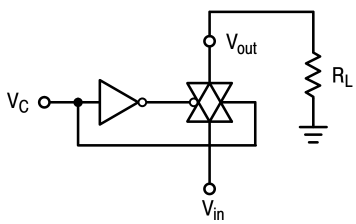


Figure 5. R_{ON} Characteristics Test Circuit

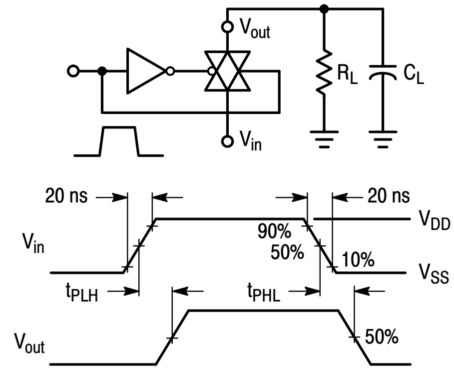


Figure 6. Propagation Delay Test Circuit and Waveforms

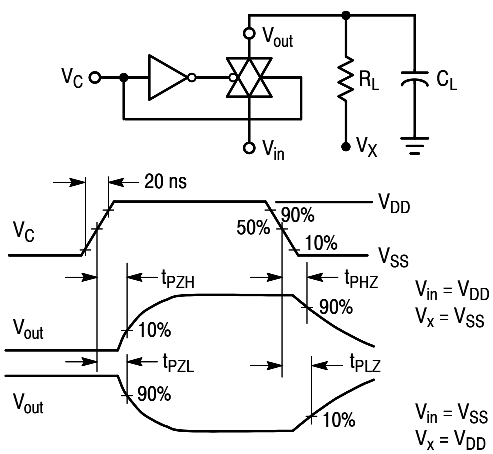


Figure 7. Turn−On Delay Time Test Circuit and Waveforms

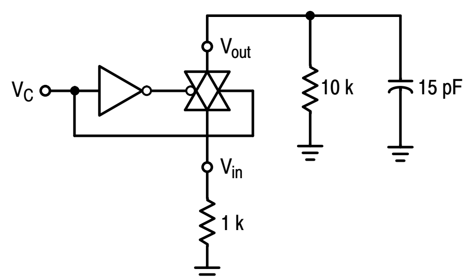


Figure 8. Crosstalk Test Circuit

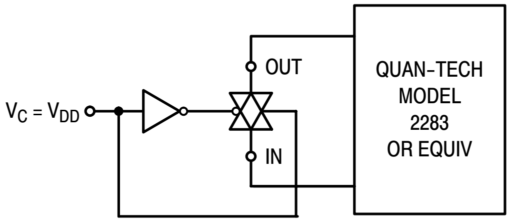


Figure 9. Noise Voltage Test Circuit

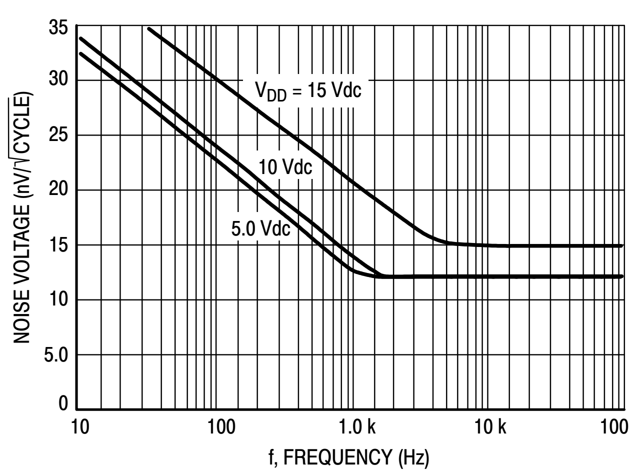


Figure 10. Typical Noise Characteristics

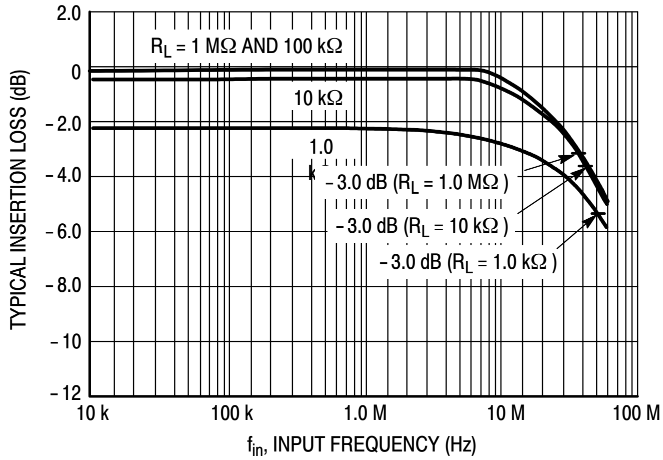


Figure 11. Typical Insertion Loss/Bandwidth Characteristics

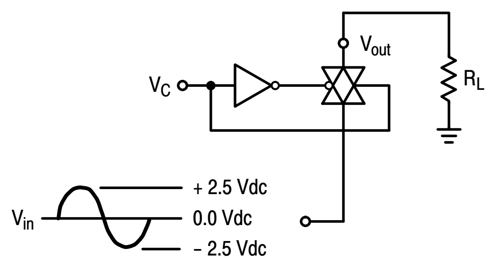


Figure 12. Frequency Response Test Circuit

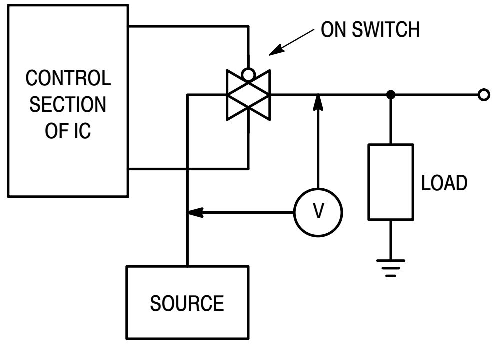


Figure 13. ∆V Across Switch

APPLICATIONS INFORMATION

Figure A illustrates use of the Analog Switch. The 0−to−5 V Digital Control signal is used to directly control a 5 V_{p-p} analog signal.

The digital control logic levels are determined by V_{DD} and V_{SS}. The V_{DD} voltage is the logic high voltage; the V_{SS} voltage is logic low. For the example, V_{DD} = +5 V logic high at the control inputs; V_{SS} = GND = 0 V logic low.

The maximum analog signal level is determined by V_{DD} and V_{SS}. The analog voltage must not swing higher than V_{DD} or lower than V_{SS}.

The example shows a 5 V_{p-p} signal which allows no margin at either peak. If voltage transients above V_{DD} and/or below V_{SS} are anticipated on the analog channels, external diodes (D_x) are recommended as shown in Figure B. These diodes should be small signal types able to absorb the maximum anticipated current surges during clipping.

The *absolute* maximum potential difference between V_{DD} and V_{SS} is 18.0 V. Most parameters are specified up to 15 V which is the *recommended* maximum difference between V_{DD} and V_{SS}.

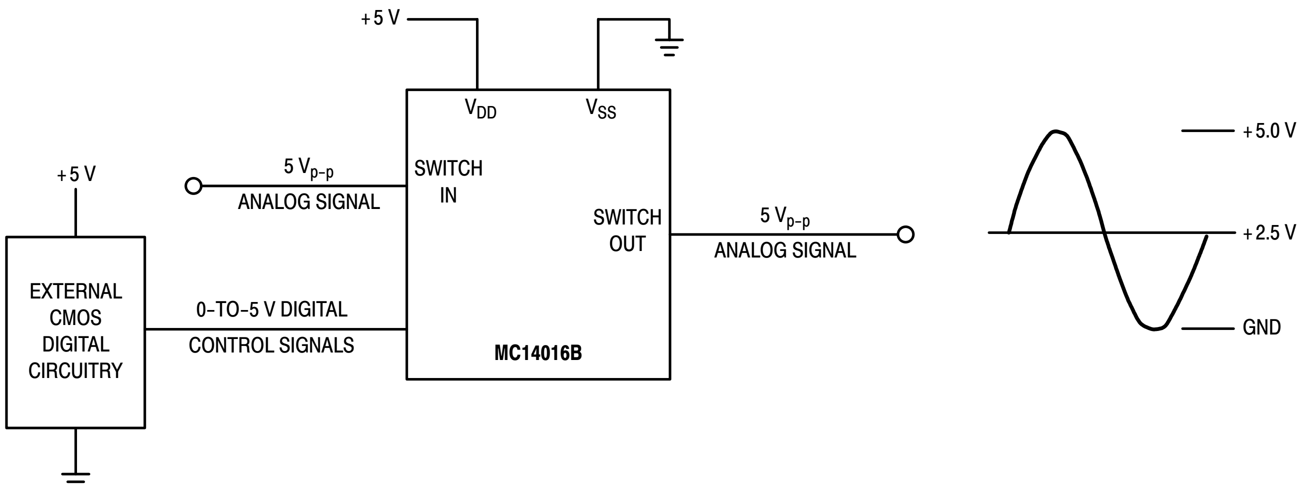


Figure A. Application Example

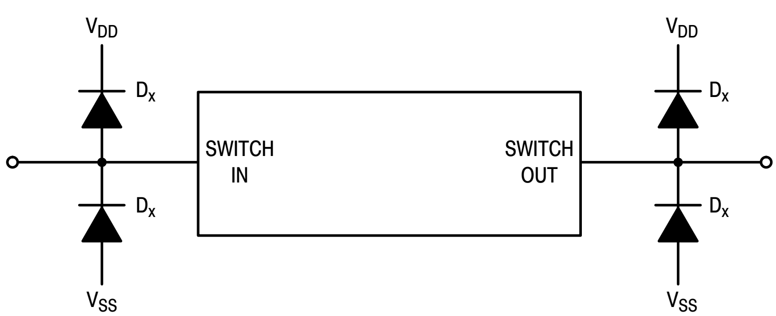
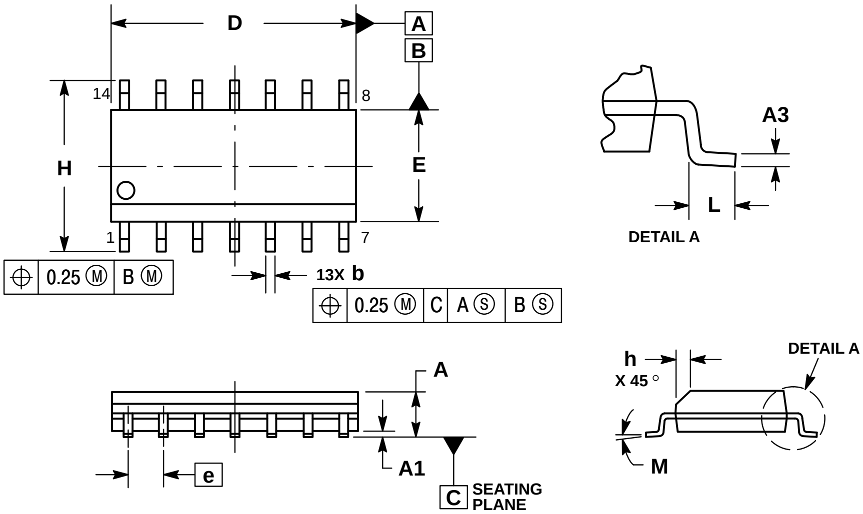


Figure B. External Germanium or Schottky Clipping Diodes

PACKAGE DIMENSIONS

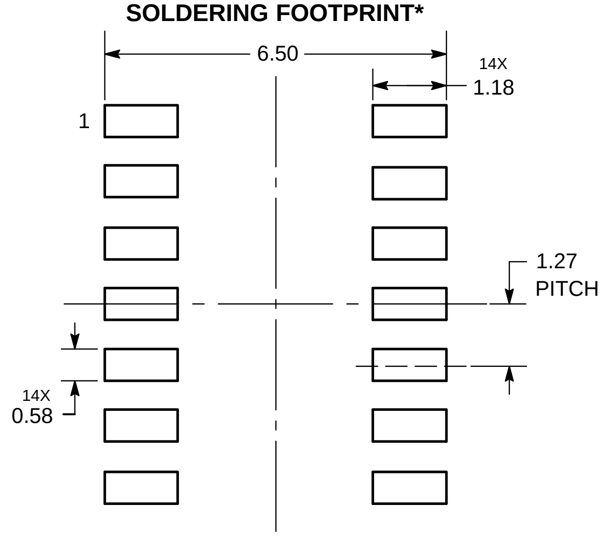
SOIC−14 NB
CASE 751A−03
ISSUE K



NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSION b DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE PROTRUSION SHALL BE 0.13 TOTAL IN EXCESS OF AT MAXIMUM MATERIAL CONDITION.
4. DIMENSIONS D AND E DO NOT INCLUDE MOLD PROTRUSIONS.
5. MAXIMUM MOLD PROTRUSION 0.15 PER SIDE.

	MILLIMETERS		INCHES	
DIM	**MIN**	**MAX**	**MIN**	**MAX**
A	1.35	1.75	0.054	0.068
A1	0.10	0.25	0.004	0.010
A3	0.19	0.25	0.008	0.010
b	0.35	0.49	0.014	0.019
D	8.55	8.75	0.337	0.344
E	3.80	4.00	0.150	0.157
e	1.27 BSC		0.050 BSC	
H	5.80	6.20	0.228	0.244
h	0.25	0.50	0.010	0.019
L	0.40	1.25	0.016	0.049
M	0 °	7 °	0 °	7 °

SOLDERING FOOTPRINT*

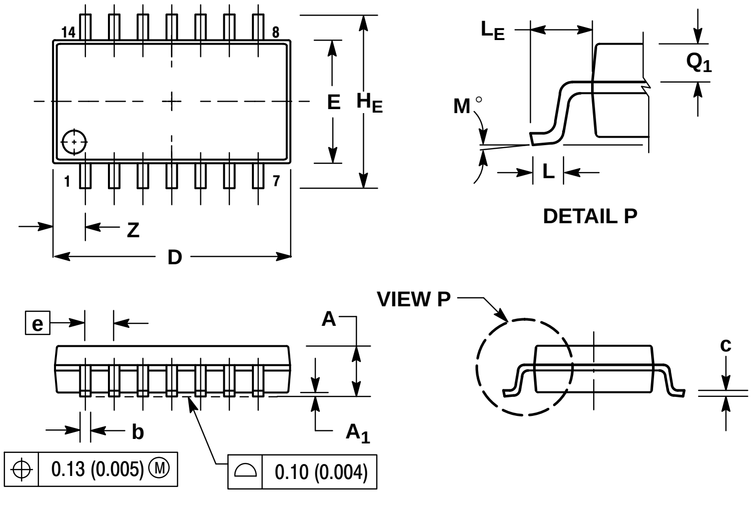


DIMENSIONS: MILLIMETERS

*For additional information on our Pb−Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

SOEIAJ−14
CASE 965
ISSUE B



NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETER.
3. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH OR PROTRUSIONS AND ARE MEASURED AT THE PARTING LINE. MOLD FLASH OR PROTRUSIONS SHALL NOT EXCEED 0.15 (0.006) PER SIDE.
4. TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY.
5. THE LEAD WIDTH DIMENSION (b) DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 (0.003) TOTAL IN EXCESS OF THE LEAD WIDTH DIMENSION AT MAXIMUM MATERIAL CONDITION. DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OR THE FOOT. MINIMUM SPACE BETWEEN PROTRUSIONS AND ADJACENT LEAD TO BE 0.46 (0.018).

	MILLIMETERS		INCHES	
DIM	MIN	MAX	MIN	MAX
A	---	2.05	---	0.081
A_1	0.05	0.20	0.002	0.008
b	0.35	0.50	0.014	0.020
c	0.10	0.20	0.004	0.008
D	9.90	10.50	0.390	0.413
E	5.10	5.45	0.201	0.215
e	1.27 BSC		0.050 BSC	
H_E	7.40	8.20	0.291	0.323
L	0.50	0.85	0.020	0.033
L_E	1.10	1.50	0.043	0.059
M	0 °	10 °	0 °	10 °
Q_1	0.70	0.90	0.028	0.035
Z	---	1.42	---	0.056

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:
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